

## SCOPE :

This specification applies to the current type Radial Leaded Inductor  
for MCD-855C-SERIES

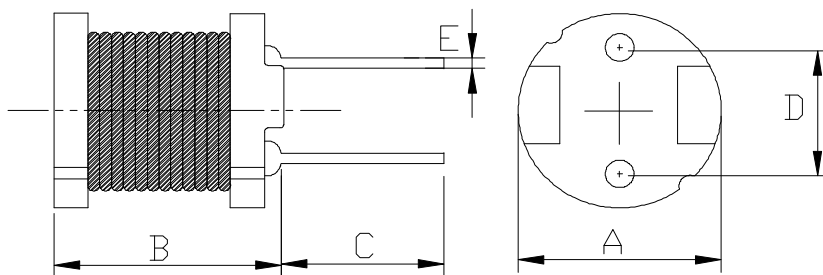
### PRODUCT IDENTIFICATION

MCD - 855C - 220 K

①      ②      ③      ④

- ① Product Code
- ② Dimensions Code
- ③ Inductance Code
- ④ Tolerance Code

## (1) SHAPES AND DIMENSIONS



A : $7.8 \pm 0.5$	mm
B : 6.5 Max.	mm
C : $15 \pm 2.0$	mm
D : $5.0 \pm 0.5$	mm
E : $\phi 0.65 \pm 0.1$	mm

## (2) ELECTRICAL SPECIFICATIONS

### SEE TABLE 1

#### TEST INSTRUMENTS

L : HP 4284A PRECISION LCR METER (or equivalent)

RDC : CHROMA MODEL 16502 MILLIOHMMETER (or equivalent)

## (3) CHARACTERISTICS

- (3)-1 Ambient temperature .....  $+60^{\circ}\text{C}$  Max.
- (3)-2 Operate temperature range .....  $-40^{\circ}\text{C} \sim +125^{\circ}\text{C}$   
(Including self temp. rise)
- (3)-3 Storage temperature range .....  $-40^{\circ}\text{C} \sim +125^{\circ}\text{C}$



MAG.LAYERS

**TABLE 1**

MAGLAYERS PT/NO.	Inductance L( $\mu$ H)	Percent Tolerance	Test Frequency	Resistance RDC( $\Omega$ )Max.	Rated DC Current	
					IDC1(A)	IDC2(A)
MCD-855C-150□	15	K,M	100kHz/0.25V	90m	2.1	2.1
MCD-855C-220□	22	K,M	100kHz/0.25V	0.12	1.7	1.9
MCD-855C-330□	33	K,M	100kHz/0.25V	0.17	1.4	1.8
MCD-855C-121□	120	K,M	100kHz/0.25V	0.59	0.76	0.80
MCD-855C-331□	330	K,M	100kHz/0.25V	1.47	0.44	0.52
MCD-855C-471□	470	K,M	100kHz/0.25V	1.95	0.38	0.43
MCD-855C-821□	820	K,M	100kHz/0.25V	3.82	0.31	0.32
MCD-855C-102□	1000	K,M	100kHz/0.25V	5.28	0.25	0.30
MCD-855C-122□	1200	J,K	1kHz/0.25V	6.03	0.23	0.26
MCD-855C-152□	1500	J,K	1kHz/0.25V	7.15	0.21	0.25
MCD-855C-182□	1800	J,K	1kHz/0.25V	8.26	0.20	0.23
MCD-855C-222□	2200	J,K	1kHz/0.25V	11.1	0.18	0.18
MCD-855C-682□	6800	J,K	1kHz/0.25V	31.7	0.098	0.11

※ □ Specify the inductance tolerance, J( $\pm 5\%$ ), K( $\pm 10\%$ ), M( $\pm 20\%$ )

※ IDC1 : Based on inductance change ( $\Delta L/L_o$  : drop 10% Max.) @ ambient temp. 25°C

IDC2 : Based on temperature rise ( $\Delta T$  : 40°C TYP.)

Rated DC Current : The less value which is IDC1 or IDC2.



#### (4) RELIABILITY TEST METHOD MECHANICAL

NO.	ITEMS	SPECIFICATIONS	CONDITIONS
1	Solderability test	More than 90% of the terminal electrode should be covered with solder.	Dipping: $245 \pm 5^{\circ}\text{C}$ , $3 \pm 1$ seconds
2	lead tensile strength test	1.0 Kg MIN.	The lead of product is pulled with a load of 1.0kg minimum until lead breakdown. The tensile force shall be recorded.
3	Vibration test	$\Delta L/L \leq \pm 7\%$ Visual:OK	The product is fixed into the vibration with amplitude of 1.52m/m at a frequency of 10~55Hz sweeping for 1min. The vibration is done at X,Y, Z direction respectively for 2 hours, totally 6 hours.
4	Soldering heat resistance test	Visual:OK Circuit:OK	The leads of product are dipped into a solder pot of $260 \pm 5^{\circ}\text{C}$ for a duration of $10 \pm 1$ sec. Nothing particular on visual and open circuitry as a result of ore testing.

#### ENVIRONMENTAL

NO.	ITEMS	SPECIFICATIONS	CONDITIONS
1	Humidity endurance test	$\Delta L/L \leq \pm 5\%$	The product is placed in a chamber of $40 \pm 2^{\circ}\text{C}$ , 90~95%RH for 96 hours. Measurement is done after the recovery of 4~24 hours.
2	High temp endurance test	$\Delta L/L \leq \pm 5\%$	The product is placed in a chamber of $80 \pm 2^{\circ}\text{C}$ , for 72 hours. Measurement is done after recovery of 4~24 hours.
3	Low temp test	$\Delta L/L \leq \pm 5\%$	The product is placed in a chamber of $-40 \pm 2^{\circ}\text{C}$ , for 96 hours. Measurement is done after recovery of 4~24 hours.
4	Thermal shock test	$\Delta L/L \leq \pm 5\%$	The specimens are placed in a chamber and the temp is then lowered to $-20 \pm 2^{\circ}\text{C}$ for one hour. The temp will raised to $+80 \pm 2^{\circ}\text{C}$ for one hour. This constitutes one cycle. Ten cycles of such testing shall be completed. Measurement is made after recovery for 4~24 hours from the completion of testing.

## (5) PACKAGE SPECIFICATION (mm)

